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May 2015



FDMS8020

N-Channel PowerTrench[®] MOSFET 30 V, 131 A, 2.5 m Ω

Features

- Max $r_{DS(on)} = 2.5 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 26 \text{ A}$
- Max $r_{DS(on)} = 3.6 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 21.5 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

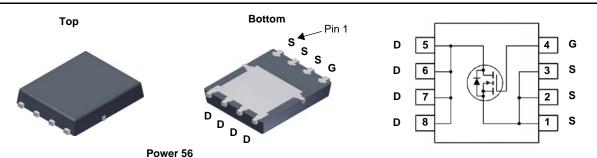


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers.It has been optimized for low gate charge, low $r_{\rm DS(on)},$ fast switching speed ang body diode reverse recovery performance.

Applications

- VRM Vcore Switching For Desktop And Server
- OringFET / Load Switching
- DC-DC Conversion
- Motor Bridge Switch



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted.

Symbol	Paramo	eter		Ratings	Units
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous	T _C = 25 °C	(Note 6)	131	
	-Continuous	T _C = 100 °C	(Note 6)	83	^
ID	-Continuous	T _A = 25 °C	(Note 1a)	26	A
	-Pulsed		(Note 5)	507	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	93	mJ
D	Power Dissipation	T _C = 25 °C		65	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Tempera	ture Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.9	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8020	FDMS8020	Power 56	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted.

Parameter

Off Characteristics								
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V		
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		14		mV/°C		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ		
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA		

Test Conditions

Min

Тур

Max

Units

On Characteristics

Symbol

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.5	3.0	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		-6		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 26 \text{ A}$		2.0	2.5	
		V _{GS} = 4.5 V, I _D = 21.5 A		2.6	3.6	mΩ
		V _{GS} = 10 V, I _D = 26 A, T _J = 125 °C		2.9	3.7	
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 26 \text{ A}$		154		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 0 V	2855	3800	pF
C _{oss}	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	1050	1400	pF
C _{rss}	Reverse Transfer Capacitance	1 = 1 1011 12	115	175	pF
R_g	Gate Resistance		0.9		Ω

Switching Characteristics

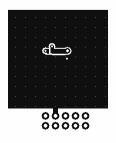
t _{d(on)}	Turn-On Delay Time		12	22	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 26 A,	5.7	12	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	32	52	ns
t _f	Fall Time		4	10	ns
Q_{g}	Total Gate Charge	V _{GS} = 0 V to 10 V	43	61	nC
Q_{g}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$	21	29	nC
Q_{gs}	Gate to Source Charge	I _D = 26 A	7.3		nC
Q_{gd}	Gate to Drain "Miller" Charge		6.0		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.1 \text{ A}$	(Note 2)	0.68	1.1	\/
		V _{GS} = 0 V, I _S = 26 A	(Note 2)	0.78	1.2	v
t _{rr}	Reverse Recovery Time	I _F = 26 A, di/dt = 100 A/μs		37	58	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/} \mu \text{S}$		18	33	nC
t _{rr}	Reverse Recovery Time	I _F = 26 A, di/dt = 300 A/μs		30	48	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 20 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{S}$		36	57	nC

Notes:

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0CA} is determined by the user's board design.



a) 50 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0%.
- 3. Starting T $_{J}$ = 25 °C; N-ch: L = 0.3 mH, I $_{AS}$ = 25 A, V $_{DD}$ = 27 V, V $_{GS}$ = 10 V.
- 4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.
- 5. Pulsed Id please refer to SOA curve for more details.
- 6. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

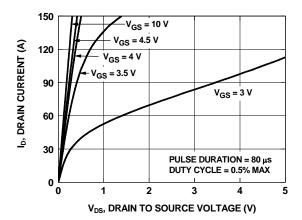


Figure 1. On-Region Characteristics

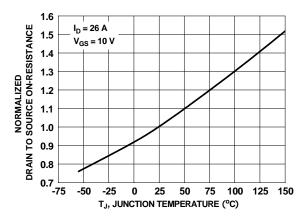


Figure 3. Normalized On-Resistance vs. Junction Temperature

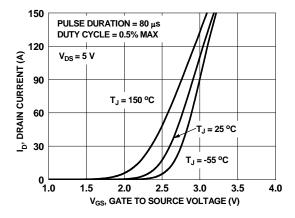


Figure 5. Transfer Characteristics

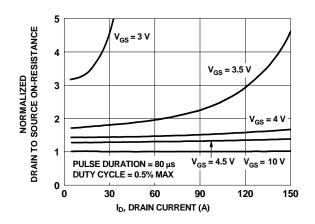


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

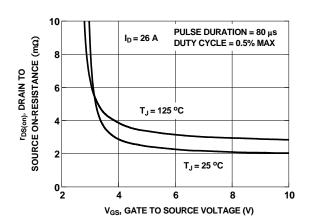


Figure 4. On-Resistance vs. Gate to Source Voltage

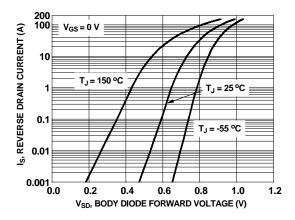


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

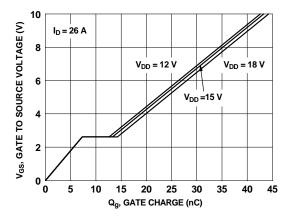


Figure 7. Gate Charge Characteristics

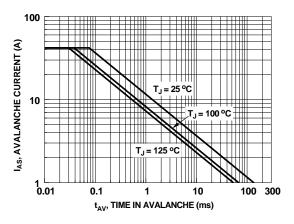


Figure 9. Unclamped Inductive Switching Capability

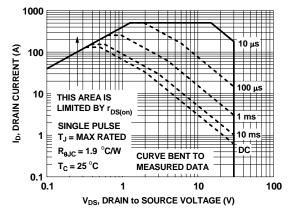


Figure 11. Forward Bias Safe Operating Area

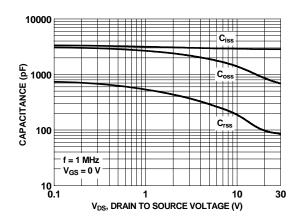


Figure 8. Capacitance vs. Drain to Source Voltage

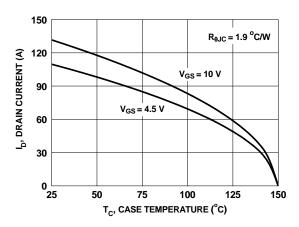


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

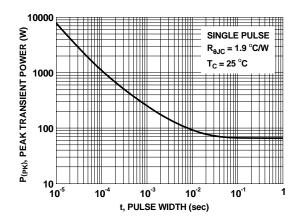


Figure 12. Single Pulse Maximum Power Dissipation



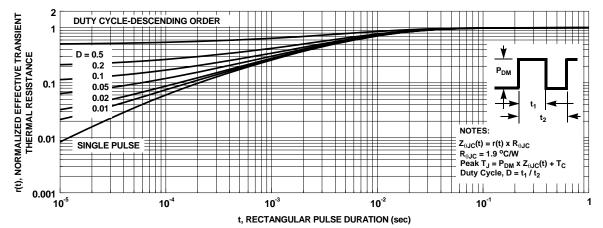
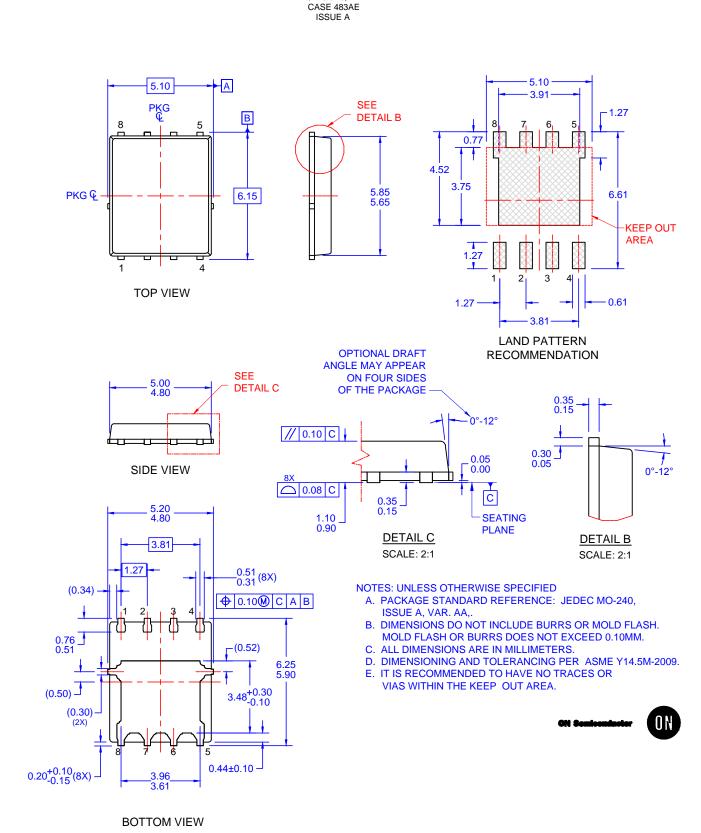


Figure 13. Junction-to-Case Transient Thermal Response Curve



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